

SKM 200 MLI 066 T



SEMITRANS[®] 5

Trench IGBT Modules

SKM 200 MLI 066 T

Target Data

Features

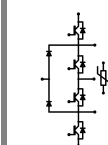
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Integrated NTC temperature sensor

Typical Applications

- UPS
- 3 Level Inverter

Remarks

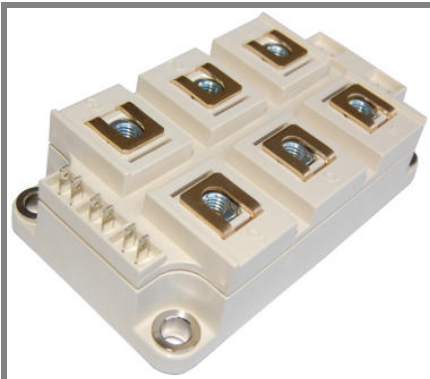
- Case temperature limited to $T_c = 125^\circ\text{C}$ max, recommended $T_{op} = -40..+150^\circ\text{C}$



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Absolute Maximum Ratings		$T_{case} = 25^\circ\text{C}$, unless otherwise specified		
Symbol	Conditions	Values		Units
IGBT				
V_{CES}	$T_j = 25^\circ\text{C}$	600		V
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	280	A
		$T_c = 80^\circ\text{C}$	210	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	400		A
V_{GES}		± 20		V
t_{psc}	$V_{CC} = 360\text{ V}; V_{GE} \leq 15\text{ V}; T_j = 150^\circ\text{C}$ $V_{CES} < 600\text{ V}$	6		μs
Inverse Diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	270	A
		$T_c = 80^\circ\text{C}$	200	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	400		A
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150^\circ\text{C}$	1310		A
Freewheeling Diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	270	A
		$T_c = 80^\circ\text{C}$	200	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	400		A
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150^\circ\text{C}$	1310		A
Module				
$I_{t(RMS)}$		500		A
T_{vj}		- 40 ... + 175		$^\circ\text{C}$
T_{stg}		- 40 ... + 125		$^\circ\text{C}$
V_{isol}	AC, 1 min.	2500		V

Characteristics		$T_{case} = 25^\circ\text{C}$, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 3,2\text{ mA}$	5	5,8	6,5	V	
I_{CES}	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES} T_j = 25^\circ\text{C}$			0,01	mA	
I_{GES}	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V } T_j = 25^\circ\text{C}$			1200	nA	
V_{CE0}			$T_j = 25^\circ\text{C}$	0,9	1	V
			$T_j = 150^\circ\text{C}$	0,7	0,8	V
r_{CE}	$V_{GE} = 15\text{ V}$		$T_j = 25^\circ\text{C}$	2,7	4,5	m Ω
			$T_j = 150^\circ\text{C}$	5	6,5	m Ω
$V_{CE(sat)}$	$I_{Cnom} = 200\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$ $T_j = 150^\circ\text{C}_{chiplev.}$		1,45	1,9	V
				1,7	2,1	V
C_{ies}	$V_{CE} = 25, V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$		12,3		nF
C_{oes}			0,76		nF	
C_{res}			0,36		nF	
R_{Gint}	$T_j = ^\circ\text{C}$		1		Ω	
$t_{d(on)}$	$R_{Gon} = 2,4\ \Omega$	$V_{CC} = 300\text{ V}$ $I_C = 200\text{ A}$			ns	
t_r					ns	
E_{on}					mJ	
$t_{d(off)}$	$R_{Goff} = 2,4\ \Omega$	$T_j = 150^\circ\text{C}$ $V_{GE} = -8\text{ V}/+15\text{ V}$			ns	
t_f					ns	
E_{off}					mJ	
$R_{th(j-c)}$	per IGBT		0,21		K/W	



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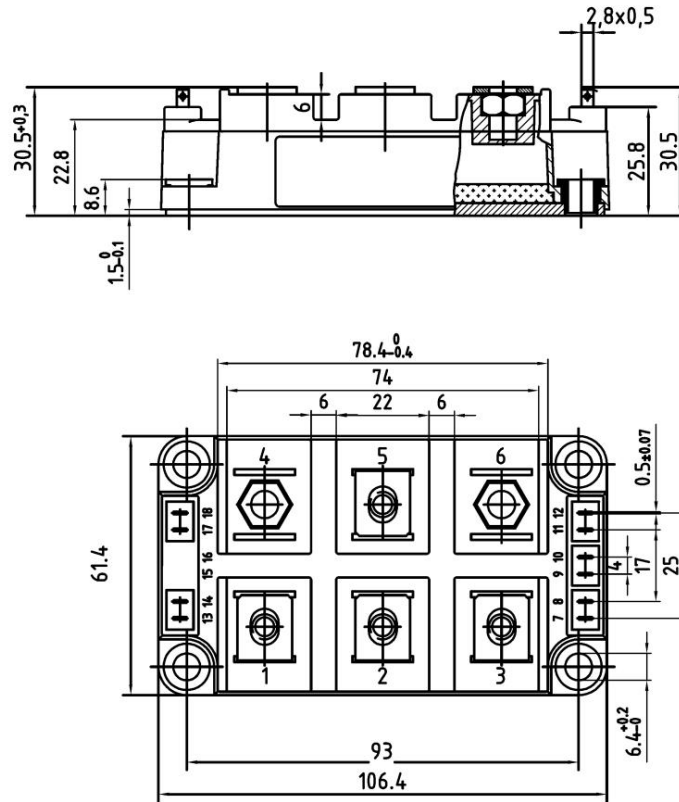
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Characteristics						
Symbol	Conditions	min.	typ.	max.	Units	
Inverse Diode						
$V_F = V_{EC}$	$I_{Fnom} = 200\text{ A}; V_{GE} = 0\text{ V}$		$T_j = 25^\circ\text{C}_{chiplev.}$	1,4	1,6	V
			$T_j = 150^\circ\text{C}_{chiplev.}$	1,4	1,6	V
V_{F0}			$T_j = 25^\circ\text{C}$	0,95	1	V
			$T_j = 150^\circ\text{C}$	0,85	0,9	V
r_F			$T_j = 25^\circ\text{C}$	2	3	mΩ
			$T_j = 150^\circ\text{C}$	2,7	3,5	mΩ
I_{RRM}	$I_F = 200\text{ A}$		$T_j = 150^\circ\text{C}$		A	
Q_{rr}					μC	
E_{rr}	$V_{GE} = -8\text{ V}; V_{CC} = 300\text{ V}$				mJ	
$R_{th(j-c)D}$	per diode		0,39		K/W	
Free-wheeling diode (Neutral Clamp Diode)						
$V_F = V_{EC}$	$I_{Fnom} = 200\text{ A}; V_{GE} = 0\text{ V}$		$T_j = 25^\circ\text{C}_{chiplev.}$	1,4	1,6	V
			$T_j = 150^\circ\text{C}_{chiplev.}$	1,4	1,6	V
V_{F0}			$T_j = 25^\circ\text{C}$	0,95	1	V
			$T_j = 150^\circ\text{C}$	0,85	0,9	V
r_F			$T_j = 25^\circ\text{C}$	2	3	V
			$T_j = 150^\circ\text{C}$	2,7	3,5	V
I_{RRM}	$I_F = 200\text{ A}$		$T_j = 150^\circ\text{C}$		A	
Q_{rr}					μC	
E_{rr}	$V_{GE} = 0\text{ V}; V_{CC} = 600\text{ V}$				mJ	
$R_{th(j-c)FD}$	per diode		0,39		K/W	
M_s	to heat sink M6	3		5	Nm	
M_t	to terminals M6	2,5		5	Nm	
w				310	g	
Temperature sensor						
R_{100}	$T_s = 100^\circ\text{C}$ ($R_{25} = 5\text{ k}\Omega$)		493±5%		Ω K	

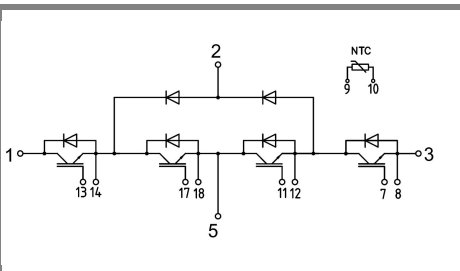
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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Case D60



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